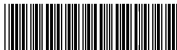


Search Notes**Application/Control No.**

10/816,451

Examiner

BENJAMIN P. GEIB

Applicant(s)/Patent under Reexamination

CHUN ET AL.

Art Unit

2181

SEARCHED

Class	Subclass	Date	Examiner
718	102	3/31/2008	BPG
712	201	3/31/2008	BPG
712	245	3/31/2008	BPG

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search	3/31/2008	BPG
NPL search (Google Scholar and IEEE Xplore)	3/31/2008	BPG
Inventor name search	3/31/2008	BPG